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November 2013

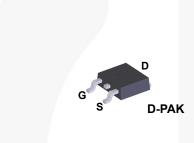
## **FQD17N08L N-Channel QFET® MOSFET** 80 V, 12.9 A, 100 mΩ

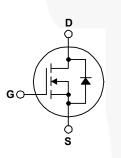
### Description

This N-Channel enhancement mode power MOSFET is produced using Fairchild Semiconductor's proprietary planar stripe and DMOS technology. This advanced MOSFET technology has been especially tailored to reduce on-state resistance, and to provide superior switching performance . Low Crss (Typ. 29 pF) and high avalanche energy strength. These devices are suitable for switched mode power supplies, audio amplifier, • 100% Avalanche Tested DC motor control, and variable switching power applications.

#### Features

- 12.9 A, 80 V, R<sub>DS(on)</sub> = 100 mΩ (Max.) @ V<sub>GS</sub> = 10 V, I<sub>D</sub> = 6.45 A
- Low Gate Charge (Typ. 8.8 nC)





#### Absolute Maximum Ratings T<sub>c</sub> = 25°C unless otherwise noted.

Symbol	Parameter	F	QD17N08LTM	Unit
V <sub>DSS</sub>	Drain-Source Voltage		80	V
I <sub>D</sub>	Drain Current - Continuous ( $T_C = 25^{\circ}C$ )		12.9	А
	- Continuous (T <sub>C</sub> = 100°C)		8.2	А
I <sub>DM</sub>	Drain Current - Pulsed (N	ote 1)	51.6	A
V <sub>GSS</sub>	Gate-Source Voltage		± 20	V
E <sub>AS</sub>	Single Pulsed Avalanche Energy (N	ote 2)	100	mJ
I <sub>AR</sub>	Avalanche Current (N	ote 1)	12.9	A
E <sub>AR</sub>	Repetitive Avalanche Energy (N	ote 1)	4.0	mJ
dv/dt	Peak Diode Recovery dv/dt (N	ote 3)	6.5	V/ns
P <sub>D</sub>	Power Dissipation ( $T_A = 25^{\circ}C$ ) *		2.5	W
	Power Dissipation ( $T_C = 25^{\circ}C$ )		40	W
	- Derate above 25°C		0.32	W/°C
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature Range		-55 to +150	°C
TL	Maximum lead temperature for soldering, 1/8" from case for 5 seconds		300	°C

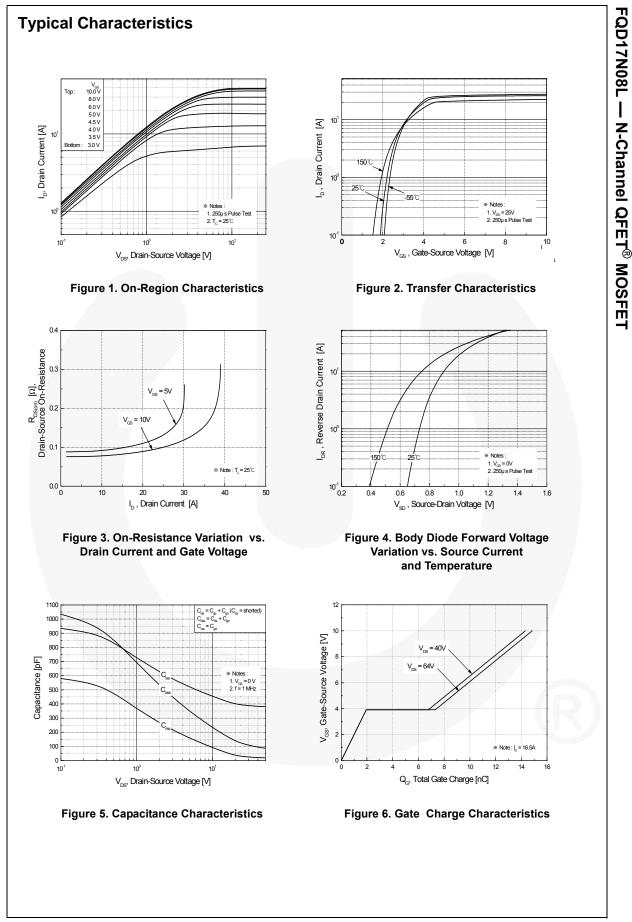
### **Thermal Characteristics**

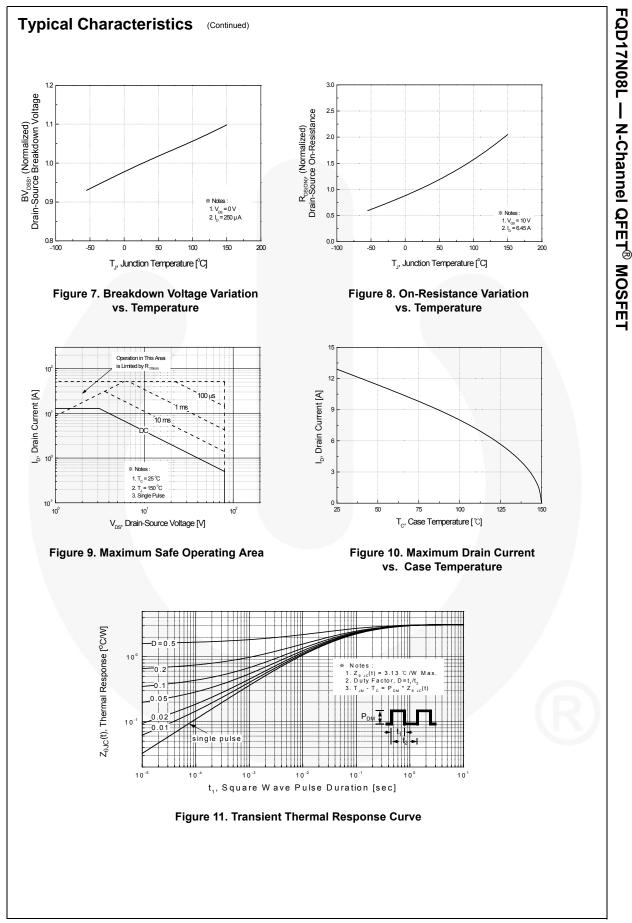
Symbol	Parameter	FQD17N08LTM	Unit
$R_{\theta JC}$	Thermal Resistance, Junction to Case, Max.	3.13	
$R_{ hetaJA}$	Thermal Resistance, Junction to Ambient (Minimum Pad of 2-oz Copper), Max.	110	°C/W
	Thermal Resistance, Junction to Ambient (*1 in <sup>2</sup> Pad of 2-oz Copper), Max.	50	

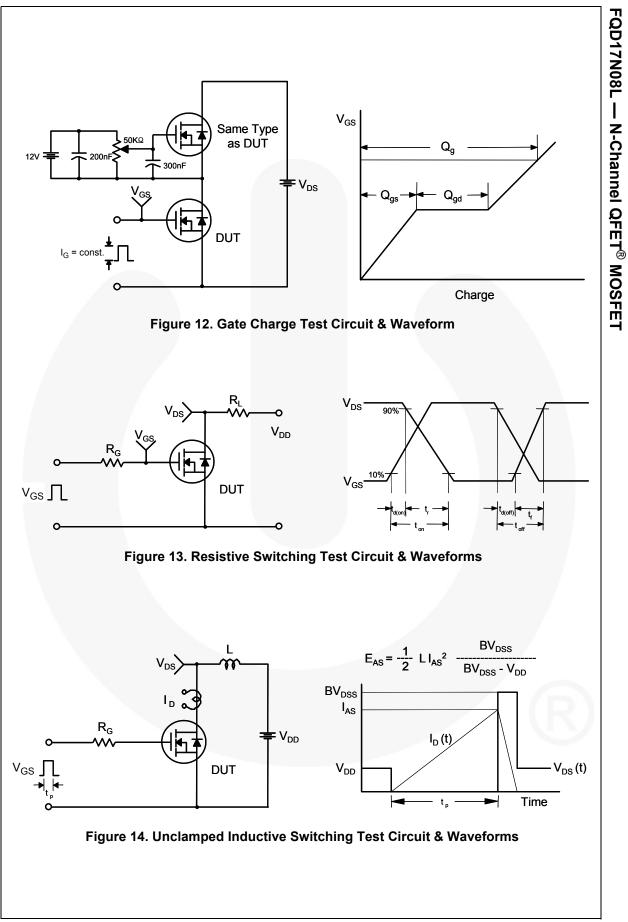
		Top Mark	1 401	Package Packing Method Ree		Reel	Size	Tape Width		Quantity	
FQD17N08LTM FQD17N08L DF			PAK Tape and Reel 330		330	mm	16 mm		2500 units		
loctrid	aal Chai	acteristics									
	Gal Chai		T <sub>C</sub> = 25°0	C unless ot	herwise noted. Test Con	ditiona		Min	T. m	Max	l lmit
Symbol		Parameter			lest Con	aitions		Min.	Тур.	Max.	Unit
Off Cha	racteristi	cs									
3V <sub>DSS</sub>	Drain-Source Breakdown Voltage			$V_{GS}$ = 0 V, I <sub>D</sub> = 250 $\mu$ A			80			V	
BV <sub>DSS</sub>	Breakdowr	Breakdown Voltage Temperature			L = 250 u.A. Referenced to 25°C				0.08		1/180
$/\Delta T_J$	Coefficient			$I_D = 250 \ \mu A$ , Referenced to $25^{\circ}C$				0.08	1	V/°C	
DSS	Zero Gate Voltage Drain Current		$V_{DS} = 80 V, V_{GS} = 0 V$ $V_{DS} = 64 V, T_C = 125^{\circ}C$					1	μΑ		
								10	μΑ		
GSSF	,	ate-Body Leakage Current, Forward			$V_{GS}$ = 20 V, $V_{DS}$ = 0 V					100	nA
GSSR	Gate-Body	Leakage Current,	Reverse	V <sub>GS</sub> =	-20 V, V <sub>DS</sub>	= 0 V				-100	nA
)n Cha	racteristi	<b>CC</b>									
GS(th)		shold Voltage		Vpe =	V <sub>GS</sub> , I <sub>D</sub> = 2	50 µA		1.0		2.0	V
R <sub>DS(on)</sub>	Static Drain	0			$10 \text{ V}, \text{ I}_{\text{D}} = 6$		-	1.0	0.076	0.100	-
-D2(0N)	On-Resista			00	5 V, I <sub>D</sub> = 6.4				0.070	0.100	0
FS	Forward Tr	ansconductance	_		25 V, I <sub>D</sub> = 6		_		11.7		S
Dynami	ic Charac	teristics		i							
Piss	Input Capa	citance		V <sub>DS</sub> = 25 V, V <sub>GS</sub> = 0 V,				400	520	pF	
Soss	Output Cap			f = 1.0 MHz				120	155	pF	
rss	Reverse Tr	ansfer Capacitano	e						29	37	pF
witchi	ng Chara	cteristics									
d(on)	Turn-On D			l					7	25	ns
u(011)	Turn-On R	,	_		<sub>0</sub> = 40 V, I <sub>D</sub> = 16.5 A, = 25 Ω	6.5 A,			290	590	ns
d(off)	Turn-Off D		_	$R_{G} = 2$					20	50	ns
:	Turn-Off Fa	,		+			(Note 4)		75	160	ns
λ <sup>g</sup>	Total Gate	Charge		Vec =	64 V In = 1	6 5 A			8.8	11.5	nC
λ <sub>gs</sub>	Gate-Sour	°			$V_{DS} = 64 \text{ V}, \text{ I}_{D} = 16.5 \text{ A},$ $V_{GS} = 5 \text{ V}$				2.0		nC
λ <sub>gd</sub>	Gate-Drain			- 63			(Note 4)		5.4		nC
<u> </u>	I							-			
Drain-S	ource Die	ode Character	ristics ar	nd Max	cimum R	atings					
S	Maximum Continuous Drain-Source Dic					t				12.9	A
SM	Maximum	Pulsed Drain-Sour	ce Diode F							51.6	А
/ <sub>SD</sub>	Drain-Sour	ce Diode Forward	Voltage		0 V, I <sub>S</sub> = 12					1.5	V
r		ecovery Time		00	0 V, I <sub>S</sub> = 16				55	-	ns
۶ <sup>ur</sup>	Reverse R	ecovery Charge		dl <sub>F</sub> / di	t = 100 A/με	6			85		nC
otes: Repetitive ra	ating : pulse-widt	h limited by maximum ju	unction temper	ature							
L = 0.83 mH	I, I <sub>AS</sub> = 12.9 A, \	$V_{\rm DD} = 25  \text{V},  \text{R}_{\rm G} = 25  \Omega,  \text{s}$	starting T <sub>J</sub> = 2								
			ig 1j = 25 C.								

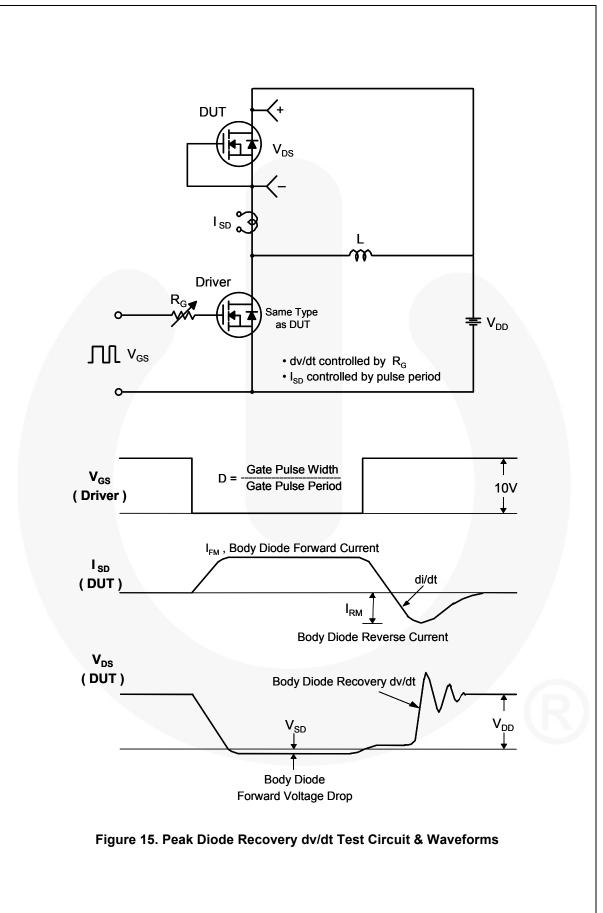
FQD17N08L — N-Channel QFET<sup>®</sup> MOSFET

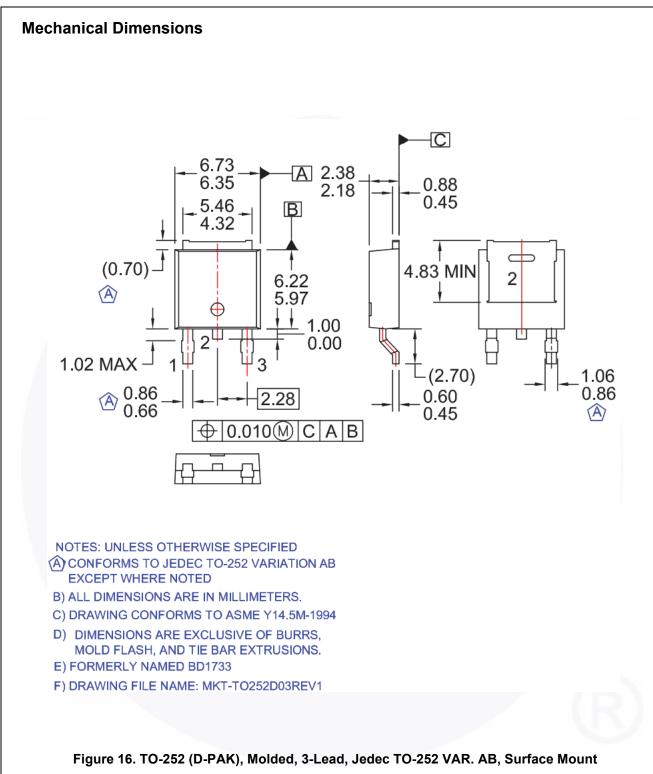
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